

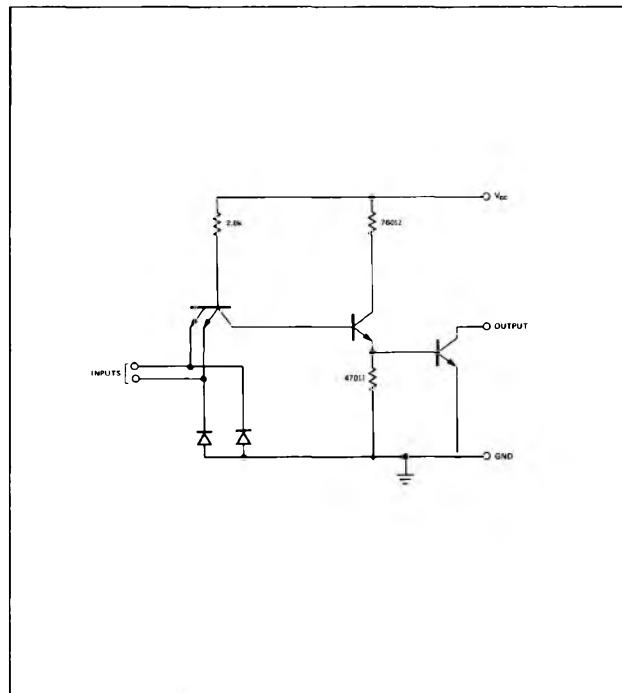
# QUADRUPLE 2-INPUT POSITIVE NAND GATE WITH OPEN COLLECTOR OUTPUT

**S54H01  
N74H01**

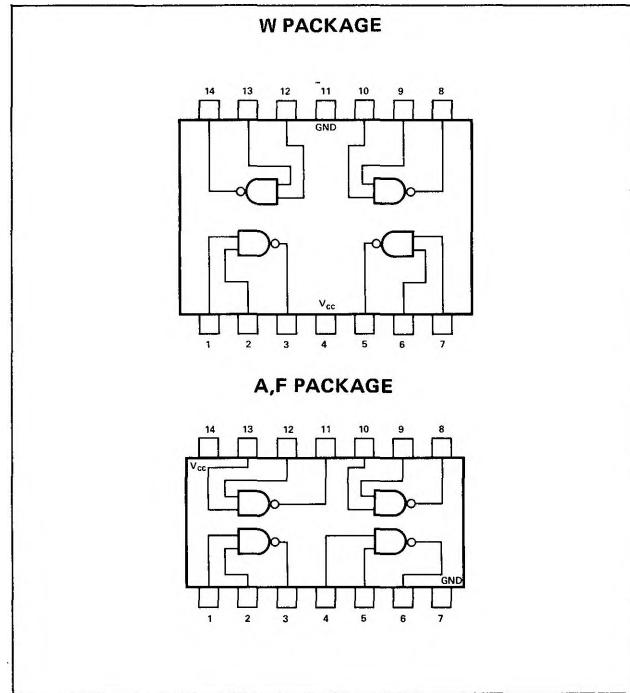
S54H01-A,F,W • N74H01-A,F

DIGITAL 54/74 TTL SERIES

## SCHEMATIC (each gate)



## PIN CONFIGURATIONS



## RECOMMENDED OPERATING CONDITIONS

	MIN	NOM	MAX	UNIT
Supply Voltage $V_{CC}$ : S54H01 Circuits N74H01 Circuits	4.5	5	5.5	V
Normalized Fan-Out from each Output, N	4.75	5	5.25	V
Operating Free-Air Temperature Range, $T_A$ : S54H01 Circuits N74H01 Circuits	-55	25	125	°C
	0	25	70	°C

## ELECTRICAL CHARACTERISTICS (over recommended operating free-air temperature range unless otherwise noted)

PARAMETER	TEST CONDITIONS*	TEST CONDITIONS*			UNIT
		MIN	TYP**	MAX	
$V_{in(1)}$	$V_{CC} = \text{MIN},$		2		V
$V_{in(0)}$	$V_{CC} = \text{MIN},$		0.8		V
$I_{out(1)}$	$V_{CC} = \text{MIN},$ $V_{out(1)} = 5.5V$		250		$\mu\text{A}$
$V_{out(0)}$	$V_{CC} = \text{MIN},$ $I_{sink} = 20\text{mA}$		0.4		V
$I_{in(0)}$	$V_{CC} = \text{MAX},$ $V_{in} = 0.4V$		-2		$\text{mA}$
$I_{in(1)}$	$V_{CC} = \text{MAX},$ $V_{CC} = \text{MAX},$ $V_{in} = 2.4V$		50		$\mu\text{A}$
$I_{CC(0)}$	$V_{CC} = \text{MAX},$ $V_{in} = 4.5V$	26	40		$\text{mA}$
$I_{CC(1)}$	$V_{CC} = \text{MAX}$	$V_{in} = 0$	6.8	10.0	$\text{mA}$

SIGNETICS DIGITAL 54/74 TTL SERIES — S54H01 • N74H01

**SWITCHING CHARACTERISTICS,  $V_{CC} = 5V$ ,  $T_A = 25^\circ C$ ,  $N = 10$**

PARAMETER		TEST CONDITIONS <sup>†</sup>	MIN	TYP <sup>**</sup>	MAX	UNIT
$t_{pd0}$	Propagation delay time to logical 0 level	$C_L = 25pF$ , $R_L = 280\Omega$		7.5	12.0	ns
$t_{pd1}$	Propagation delay time to logical 1 level	$C_L = 25pF$ , $R_L = 280\Omega$		10.0	15.0	ns

\* For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.

\*\* All typical values are at  $V_{CC} = 5V$ ,  $T_A = 25^\circ C$ .

† Load resistor  $R_L$  is connected from  $V_{CC}$  to the output, and load capacitor  $C_L$  is connected from the output to ground.